

Notice of References Cited	Application/Control No. 10/623,578	Applicant(s)/Patent Under Reexamination BLANK ET AL.	
	Examiner Kade Ariani	Art Unit 1651	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,580,787	12-1996	Wessels et al.	435/320.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	De Vos, Antonie van Leeuwenhoek 1996, Vol.70, p.223-242.
	V	Sijpesteijn, Antonie van Leeuwenhoek 1970, Vol.36, p.335-348.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.